The manufacturer may use the mark:



#### Reports:

DET 11-08-054 R003 V0R1 IEC 61508 Assessment X3301, X3302

DET 11-08-054 R002 V1 R3 X330x FMEDA Report

#### Validity:

This assessment is valid for the X3301, X3302 IR Flame Detector.

This assessment is valid until October 1, 2015. Revision 1.1 September 28, 2012



# Certificate / Certificat

# Zertifikat / 合格証

## DET 1108054 C001

exida hereby confirms that the:

## X3301, X3302 **Multispectrum IR Flame Detectors**

## **Detector Electronics Corporation** Minneapolis, MN - USA

Has been assessed per the relevant requirements of:

IEC 61508 : 2010 Parts 1-7

and meets requirements providing a level of integrity to:

#### Systematic Integrity: SIL 2 Capable

#### **Random Integrity: Type B Element**

PFD<sub>AVG</sub> and Architecture Constraints must be verified for each application

#### Safety Function:

The Multispectrum IR Flame Detector will sense infrared emission from flame sources and signal the 4 –20 mA or relay output to indicate the potentially dangerous condition.

**Application Restrictions:** 

The unit must be properly designed into a Safety Instrumented Function per the Safety Manual requirements.



John C Yozallinas Evaluating Assessor

Certifying Assessor

Page 1 of 2

#### X3301, X3302 Multispectrum IR Flame Detectors

Detector Electronics Corporation

Minneapolis, MN - USA

## Certificate / Certificat / Zertifikat / 合格証

### DET 1108054 C001

### Systematic Integrity: SIL 2 Capable Random Integrity: Type B Element

PFD<sub>AVG</sub> and Architecture Constraints must be verified for each application

SIL 2 Capability:

The product has met manufacturer design process requirements of Safety Integrity Level (SIL) 2. These are intended to achieve sufficient integrity against systematic errors of design by the manufacturer.

A Safety Instrumented Function (SIF) designed with this product must not be used at a SIL level higher than stated without "prior use" justification by end user or diverse technology redundancy in the design.

#### IEC 61508 Failure Rates in FIT\*

Device	$\lambda_{SD}$	λ <sub>su</sub>	$\lambda_{DD}$	$\lambda_{DU}$	SFF
X3301, X3302 Relay	1777	360	634	124	95.7%
X3301, X3302 Current	0	359	2448	116	96.0%
X3301, X3302 mA w/HART	0	363	2615	133	95.7%

#### SIL Verification:

The Safety Integrity Level (SIL) of an entire Safety Instrumented Function (SIF) must be verified via a calculation of  $PFD_{AVG}$  considering redundant architectures, proof test interval, proof test effectiveness, any automatic diagnostics, average repair time and the specific failure rates of all products included in the SIF. Each subsystem must be checked to assure compliance with minimum hardware fault tolerance (HFT) requirements.

\* FIT = 1 failure / 10<sup>9</sup> hours



64 N Main St Sellersville, PA 18960

Form	Version	Date
C61508	2.7-2	Mar 2011